

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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C4AQ, Radial, 2 or 4 Leads, 500 - 1,500 VDC, for DC Link (Automotive Grade)



Overview

C4AQ capcitors are polypropylene metallized film with rectangular plastic box type filled with resin (white and grey color) and 2 or 4 tinned copper wires.

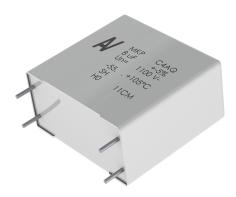
Automotive grade devices meet the demanding Automotive Electronics Council's AEC-Q200 qualification requirements.

Applications

Typical applications include DC filtering and energy storage.

Benefits

- · Self-healing
- · Low losses
- High ripple current
- · High capacitance density
- · High contact reliability
- · Suitable for high frequency applications
- · Automotive (AEC-Q200) grades

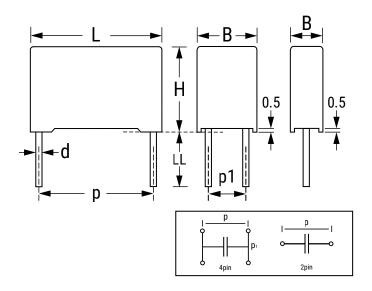


Part Number System

C4	A	Q	U	В	W	5270	1	3	N	٦
Series	Туре	Application	Rated Voltage (VDC)	Case	Terminals Code	Capacitance Code (pF)	C-Spec	Lead Diameter (mm)	Size Code: B x H x L (mm)	Tolerance
C4 = MKP Power Capacitors	A = Box, wire terminals	Q = DC Link Automotive Grade	L = 500 C = 650 I = 800 Q = 1,100 U = 1,300 S = 1,500	B = Box, plastic case E = Extended box, plastic case	U = 2 pins W = 4 pins	Digits two - four indicate the first three digits of the capacitance value. First digit indicates the number of zeros to be added.	A = Standard B - Z = Special	1 = 0.8 2 = 1.0 3 = 1.2	Digit 6 = B W = 11 x 20 x 31.5 X = 13 x 25 x 31.5 Y = 14 x 28 x 31.5 1 = 19 x 29 x 31.5 E = 20 x 40 x 42 J = 28 x 37 x 42 L = 30 x 45 x 42 O = 35 x 50 x 42 M = 30 x 45 x 57.5 N = 35 x 50 x 57.5 Digit 6 = E A = 45 x 56 x 57.5 N = 45 x 65 x 57.5	J = 5% K = 10%



Dimensions - Millimeters



Size	Code	р		p 1			В		1		L	L	L		d
Digit 6	Digit 14	Nominal	Tolerance	Nominal	Tolerance	Nominal	Tolerance	Nominal	Tolerance	Nominal	Tolerance	Nominal	Tolerance	Nominal	Tolerance
В	W	27.5	±0.4	-	-	11.0	+0.3	20.0	+0.2	31.5	+0.5	6	+0/-2	0.8	±0.05
В	Х	27.5	±0.4	-	-	13.0	+0.3	25.0	+0.2	31.5	+0.5	6	+0/-2	0.8	±0.05
В	Υ	27.5	±0.4	-	-	14.0	+0.3	28.0	+0.2	31.5	+0.5	6	+0/-2	0.8	±0.05
В	1	27.5	±0.4	-	-	19.0	+0.3	29.0	+0.2	31.5	+0.5	6	+0/-2	0.8	±0.05
В	2	27.5	±0.4	-	-	22.0	+0.3	37.0	+0.2	31.5	+0.5	6	+0/-2	0.8	±0.05
В	F	37.5	±0.4	5.1/10.2	±0.4	20.0	+0.4	40.0	+0.2	42.0	+0.6	6	+0/-2	1.2	±0.05
В	J	37.5	±0.4	10.2	±0.4	28.0	+0.4	37.0	+0.2	42.0	+0.6	6	+0/-2	1.2	±0.05
В	L	37.5	±0.4	20.3	±0.4	30.0	+0.4	45.0	+0.2	42.0	+0.6	6	+0/-2	1.2	±0.05
В	0	37.5	±0.4	20.3	±0.4	35.0	+0.4	50.0	+0.2	42.0	+0.6	6	+0/-2	1.2	±0.05
В	М	52.5	±0.4	20.3	±0.4	30.0	+0.5	45.0	+0.3	57.5	+0.8	6	+0/-2	1.2	±0.05
В	N	52.5	±0.4	20.3	±0.4	35.0	+0.5	50.0	+0.3	57.5	+0.8	6	+0/-2	1.2	±0.05
E	Α	52.5	±0.4	20.3	±0.4	45.0	+0.5	56.0	+0.3	57.5	+0.8	6	+0/-2	1.2	±0.05
Е	В	52.5	±0.4	20.3	±0.4	45.0	+0.5	65.0	+0.3	57.5	+0.8	6	+0/-2	1.2	±0.05

Qualification

Reference Standards	IEC 61071, EN61071, VDE0560				
Climatic Category	55/105/56 according to IEC 60068-1				

Automotive Grade products meet or exceed the requirements outlined by the Automotive Electronics Council. Details regarding test methods and conditions are referenced in document AEC-Q200, Stress Test Qualification for Passive Components. For additional information regarding the Automotive Electronics Council and AEC-Q200, please visit their website at www.aecouncil.com.



General Technical Data

Dielectric	Polypropylene metallized film, non-inductive type, self-healing property
Application	DC filtering, DC link
Special Features	AEC-Q200 qualified
Climatic Category	55/105/56 IEC 60068-1
Maximum Operating Temperature	+105°C
	500h + 500h at 1.3 x V _{NDC} at 70°C
Endurance Test	500h + 500h at 1.0 x V _{OP85} at 85°C
	500h + 500h at 1.0 x V _{0P105} at 105°C
Standard	IEC 61071, EN61071, VDE0560, AEC-Q200
Protection	Solvent resistant plastic case UL94 V-0 compliant Thermosetting resin sealing UL94 V-0 compliant
Installation	Any position
Leads	Tinned copper wires - standard lead wire length 6 (+0/-2) mm
Packaging	Packed in cardboard trays with protection for the terminals
RoHS Compliance	Compliant with the restricted substance requirements of Directive 2011/65/EU

Electrical Characteristics

Rated Capacitance Range	1 to 210 μF					
Rated Voltage (V _{NDC}) Range	500 to 1,500 VDC					
Capacitance Tolerance	$\pm 5\%$ (J) or $\pm 10\%$ (K) measured at T = $\pm 25^{\circ}$ C $\pm 5^{\circ}$ C					
Dissipation Factor PP Typical (tgδ0)	≤ 0.0002 at 10 kHz with T = 25°C ±5°C					
Surge Voltage	1.5 * V_{NDC} for maximum 10 times in lifetime at 25°C ±5°C					
Overveltage (IEC 61071)	1.15 * V_{NDC} for maximum 30 minutes, once per day					
Overvoltage (IEC 61071)	1.3 * V _{NDC} for maximum 1 minute, once per day					
Peak Non-Repetitive Current	1.5 * I _{PKR} , for maximum 1,000 times in lifetime					
Insulation Resistance	IR x C \geq 30.000 seconds at 100 VDC 1 minute at T = +25°C ±5°C					
Capacitance Deviation in Operation	±2.0% max. on capacitance value measured at T = +25°C ±5°C					
Temperature Storage	-40 to +80°C					
Storage time	≤ 36 months from the date marked on the label glued to the package					
Permissible Relative Humidity - Storage	Annual average ≤ 70%, 85% on 30 days/year randomly distributed throughout year. Dewing not admissible.					



Life Expectancy

	100,000 hours at V_{NDC} at hot spot temperature T_{HS} = +70°C					
Life Expectancy	100,000 hours at V_{OP85} at hot spot temperature T_{HS} = +85°C					
	10,000 hours at V_{OP105} at hot spot temperature T_{HS} = +105°C					
Capacitance Drop at End of Life	-5% (typical)					
Failure Rate IEC 61709	≤300 FIT at V _{OP85} at hot spot temperature T _{HS} = +85°C					
Failule Rate IEC 61709	≤200 FIT at V _{NDC} at hot spot temperature T _{HS} = +70°C					

Test Method

Test Voltage Between Terminals	$1.5 * V_{NDC}$ for 10 seconds or $1.65 * V_{NDC}$ for 2 seconds, at T = $+25 ° C \pm 5 ° C$				
Test Voltage Between Terminals and Case	3.2 kVAC 50 Hz for 2 seconds				
Damp Heat	IEC 60068-2-78				
Change of Temperature	IEC 60068-2-14				
Biased Humidity test 40°C/93% R.H. at V _{NDC} - 1,000 hours	$ \Delta C/C_0 \le 5\%$ $ \Delta DF/DF_0 \le 200\%$ (at 10 kHz) $IR \ge 50\%$ of initial limit"				
Biased Humidity test 60°C/95% R.H. at V _{NDC} - 1,000 hours	$ \Delta C/C_0 \le 5\%$ $ \Delta DF/DF_0 \le 200\%$ (at 10 kHz) IR ≥ 100 MΩ				

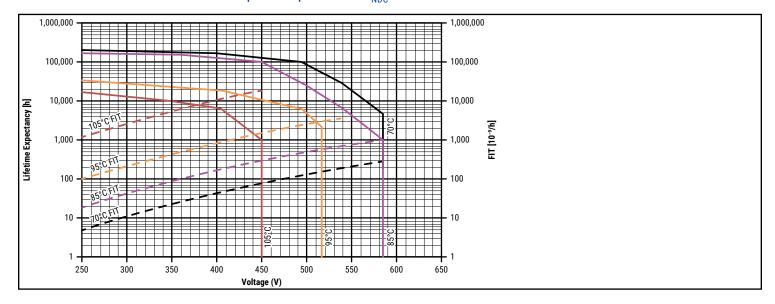
Operative Voltage Derating

	Symbol		Voltage (VDC)							
Rated Voltage at 70°C (T _{HS})	U _{NDC}	500	650	800	1,100	1,300	1,500	100,000		
Operating Voltage at 85°C (T _{HS})	U _{0P85}	450	600	700	900	1,100	1,200	100,000		
Operating Voltage at 105°C (T _{HS})	U _{0P105}	350	450	550	700	850	900	10,000		

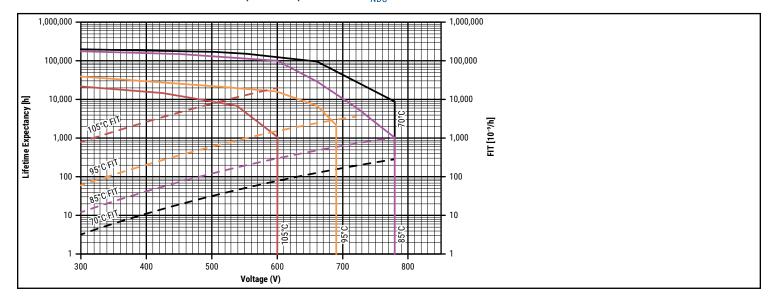


Life Expectancy/Failure Quota Graphs

Lifetime Curve & FIT at Hot Spot Temperature - U_{NDC} = 500 VDC



Lifetime Curve & FIT at Hot Spot Temperature - U_{NDC} = 650 VDC



Notes:

 $T_{HS} = T_{AMB} + \Delta T$

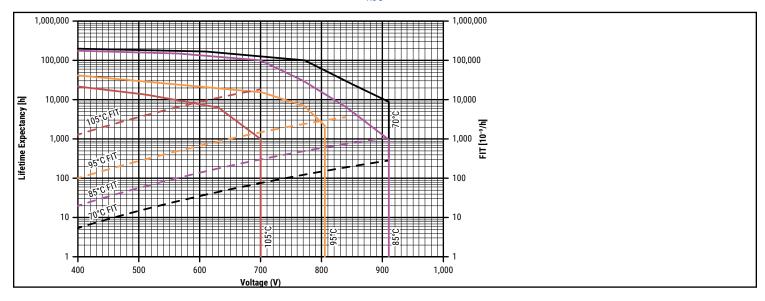
 $\Delta T = ESR * I_{rms}^2 * Rth$

 I_{rms} should be limited to values granting $\Delta T \le 30$ °C

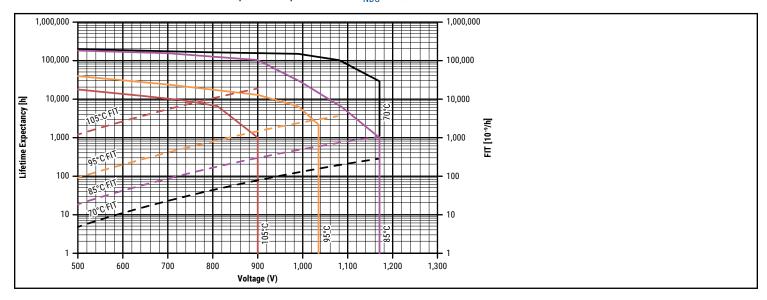


Life Expectancy/Failure Quota Graphs cont'd.

Lifetime Curve & FIT at Hot Spot Temperature - U_{NDC} = 800 VDC



Lifetime Curve & FIT at Hot Spot Temperature - U_{NDC} = 1,100 VDC

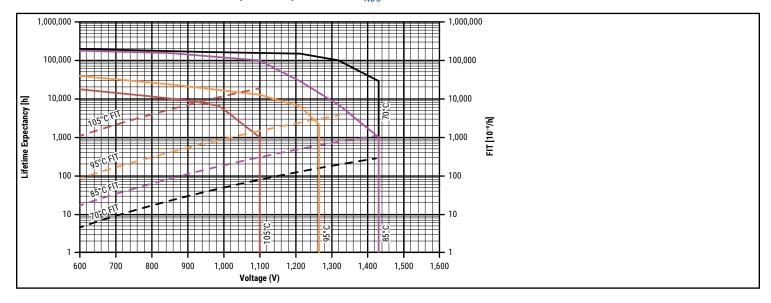


Notes: $T_{HS} = T_{AMB} + \Delta T$ $\Delta T = ESR * I_{rms}^2 * Rth$ I_{rms} should be limited to values granting $\Delta T \le 30 ^{\circ}C$

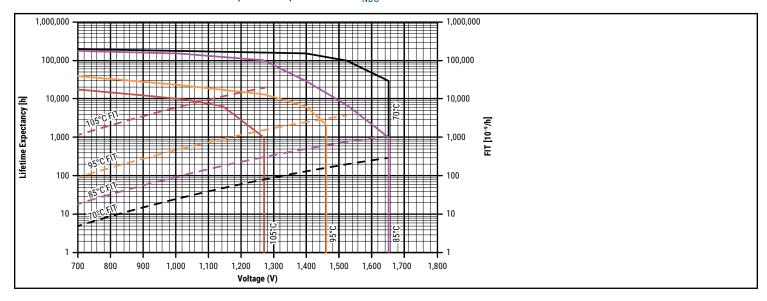


Life Expectancy/Failure Quota Graphs cont'd.

Lifetime Curve & FIT at Hot Spot Temperature - U_{NDC} = 1,300 VDC



Lifetime Curve & FIT at Hot Spot Temperature - $U_{\rm NDC}$ = 1,500 VDC



Notes: $T_{HS} = T_{AMB} + \Delta T$ $\Delta T = ESR * I_{rms}^2 * Rth$ I_{rms} should be limited to values granting $\Delta T \le 30 ^{\circ}C$



Environmental Compliance

As an environmentally conscious company, KEMET is working continuously to improveme the environmental effects of both our capacitors and their production.

In Europe, due to the RoHS Directive, and in some other geographical areas such as China, legislation has been put in place to prevent the use of some hazardous materials, including lead (Pb) in electronic equipment. All products in this catalog are produced to help our customers' obligations to guarantee their products to fulfill these legislative requirements. The only material of concern in our products has been lead (Pb), which has been removed from all designs to fulfill the requirement of containing less than 0.1% of lead in any homogeneous material.

KEMET will closely follow any changes in legislation on a global basis and make any necessary changes to its products whenever needed.

Some customer segments including medical, defense and automotive electronics may still require the use of lead in electrode coatings. To clarify the situation and distinguish products, the following symbols are used on the packaging labels for RoHS compliant and Pb-free capacitors.

Because of customer requirements, additional markings such as "LF" for lead-free or "LFW" for lead-free wires may appear on the packaging label.

Materials & Environment

The selection of materials used by KEMET for the production of capacitors is the result of extensive experience and constant attention to environmental protection. KEMET selects its suppliers according to ISO 9001 standards and carries out statistical analysis on the materials purchased before acceptance. All materials are, to the company's present knowledge, non-toxic and free from cadmium, mercury, chrome and compounds, polychlorine triphenyl (PCB), bromide and chlorine dioxins bromurate clorurate, CFC and HCFC, and asbestos.

Green Products

All KEMET power film products are ROHS Compliant.

Insulation Resistance

When the capacitor temperature increases, the insulation resistance decreases. This is due to increased electron activity. Low insulation resistance can also be the result of moisture trapped in the windings, caused by a prolonged exposure to excessive humidity.



Dissipation Factor

Dissipation factor is a complex function involved with the inefficiency of the capacitor. The $tg\delta$ may change up and down with increased temperature. For more information, please refer to Performance Characteristics.

Sealing

Hermetically Sealed Capacitors

When the temperature increases, the pressure inside the capacitor increases. If the internal pressure is high enough, it can cause a breach in the capacitor which can result in leakage, impregnation, filling fluid or moisture susceptibility.

Resin Encased/Wrap & Fill Capacitors

The resin seals on resin encased and wrap and fill capacitors will withstand short-term exposure to high humidity environments without degradation. Resins and plastic tapes will form a pseudo-impervious barrier to humidity and chemicals. These case materials are somewhat porous and through osmosis can cause contaminants to enter the capacitor. The second area of contaminated absorption is the lead-wire/resin interface. Since resins cannot bond 100% to tinned wires, there can be a path formed up to the lead wire into the capacitor section. Aqueous cleaning of circuit boards can aggravate this condition.

Barometric Pressure

The altitude at which hermetically sealed capacitors are operated controls the voltage rating of the capacitor. As the barometric pressure decreases, the susceptibility to terminal arc-over increases. Non-hermetic capacitors can be affected by internal stresses due to pressure changes. This can be in the form of capacitance changes or dielectric arc-over as well as low insulation resistance. Heat transfer can also be affected by altitude operation. Heat generated in operation cannot be dissipated properly and can result in high RI2 losses and eventual failure.

Radiation

Radiation capabilities of capacitors must be taken into consideration. Electrical degradation in the form of dielectric embitterment can take place causing shorts or opens.



Table 1 - Ratings & Part Number Reference

Value (µF)	VDC		Dime	nsions	(mm)		dV/dt	lpkr	ESL	ESR 70°C at 10 kHz	Irms* 70°C at 10 kHz	Rth (HS/Amb)	Packaging Quantity	PART NUMBER
Cap		В	Н	L	P	P1	V/µs	Apk	nH	mΩ	Arms	(°C/W)		
100 ¹	800	45	65	57.5	52.5	20.3	9	883	45	1.9	30.5	7	18	C4AQIEW6100A3BJ
85 ¹	800	45	56	57.5	52.5	20.3	9	728	41	2.5	25.5	8	18	C4AQIEW5850A3AJ
60	800	35	50	57.5	52.5	20.3	9	530	35	3.6	19.5	10	23	C4AQIBW5600A3NJ
45 55	800 800	30 35	45 50	57.5 57.5	52.5 52.5	20.3	9	389 485	35 35	4.4 3.6	16 19	12 10	27 23	C4AQIBW5450A3MJ C4AQIBW5550A3NJ
40	800	35	50		37.5	20.3	13	524	35	2.2	21.5	13		C4AQIBW5400A30J
30	800	30	45	42 42	37.5	20.3	13	389	30	3.2	16.5	15	36 30	C4AQIBW5300A3LJ
20	800	28	37	42	37.5	10.2	13	262	30	4.7	12.5	18	36	C4AQIBW5200A3JJ
15	800	20	40	42	37.5	10.2	13	196	30	6.2	10	20	58	C4AQIBW5150B3FJ
15	800	20	40	42	37.5	5.1	13	196	30	6.2	10	20	58	C4AQIBW5150A3FJ
12.5	800	22	37	31.5	27.5	\	19	241	28	5.5	10	23	64	C4AQIBU5125A12J
8	800	19	29	31.5	27.5	\	19	154	26	7.3	8	29	72	C4AQIBU4800A11J
5	800	14	28	31.5	27.5	\	19	96	26	10.7	6	33	96	C4AQIBU4500A1YJ
4	800	13	25	31.5	27.5	\	19	77	25	12.9	5.5	36	234	C4AQIBU4400A1XJ
2.7	800	11	20	31.5	27.5	\	19	51	25	18.3	4	44	256	C4AQIBU4270A1WJ
0.7	000	4.2	00	01.5	07.5					= 700 VDC; U _{OP105}			054	0.44.01011.4070.4411.
130 '	000	45	00	37.3	52.5		Ţ.						10	C4AUCEW013UA3BJ
110 ¹	650	45 45	65	57.5	52.5	20.3	6	754	41	2.2 1.7	32	δ 7	18 18	C4AQCEW6130A3BJ
75 110 ¹	650 650	35 45	50 56	57.5 57.5	52.5 52.5	20.3 20.3	6 6	435 625	35 41	3.1 2.2	20.5 27	10 8	23 18	C4AQCBW5750A3NJ C4AQCEW6110A3AJ
55 75	650	30	45	57.5	52.5	20.3	•	319	35	4.1	16.5	12	=:	C4AQCBW5550A3MJ
50	650	35	50	42	37.5	20.3	9 6	430	35	2	22.5	13	30 27	C4AQCBW5500A30J
40	650	30	45	42	37.5	20.3	9	344	30	2.8	18	15	36	C4AQCBW5400A3LJ
30	650	28	37	42	37.5	10.2	9	255	30	3.6	14	18 15	36	C4AQCBW5300A3JJ
20	650	20	40	42	37.5	10.2	9	172	30	5.3	11	20	58	C4AQCBW5200A3FJ
15	650	22	37	31.5	27.5	10.0	13	190	28	5.3	10.5	23	64	C4AQCBU5150A12J
10	650	19	29	31.5	27.5	\	13	127	26	6.8	8.5	29	72	C4AQCBU5100A11J
7	650	14	28	31.5	27.5	\	13	88	26	9	7	33	96 70	C4AQCBU4700A1YJ
5.6	650	13	25	31.5	27.5	\	13	71	25	10.7	6	36	234	C4AQCBU4560A1XJ
3.3	650	11	20	31.5	27.5	,	13	41	25	17	4	44	256	C4AQCBU4330A1WJ
0.0	U _{NDC} at 70°C = 650 VDC; U _{OP8S} at 85°C = 600 VDC; U _{OP10S} at 105°C = 450 VDC													
Z 1U '	500	45	05	57.5	52.5							•	18	C4AQLEW0ZIUA3BK
210 ¹	500	45 45	65	57.5	52.5	20.3	4 4	780 840	41	1.8	29.5 35.5	8 7	18 18	C4AQLEW6170A3AK C4AQLEW6210A3BK
130 170 ¹	500	35 45	50 56	57.5 57.5	52.5	20.3	4	780	35 41	1.8	23	10 8	23 18	C4AQLBW6130A3NK
130	500	35	50	57.5	52.5 52.5	20.3	4	581	35	2.4	23	12	27	C4AQLBW6100A3MK
90 100	500 500	35 30	50 45	42 57.5	37.5	20.3 20.3	4	585 442	35 35	1.5 3	26 19	13 12	30 27	C4AQLBW5900A30K
70	500	30 35	45	42	37.5	20.3	7	464	30	2.1	20.5	15	36	C4AQLBW5700A3LK
50 70	500		37 45	42	37.5		7		30		16	18 15		C4AQLBW5500A3JK
40 50	500	20 28	40	42	37.5	10.2 10.2	7 7	262 332	30	3.5 2.8	13.5	20	58 36	C4AQLBW5400A3FK
25	500	22	37	31.5	27.5	10.2	10	245	28	4.5	11.5	23	64	C4AQLBU5250A12K
15	500	19	29	31.5	27.5	\	10	147	26	6	8.5	29	72	C4AQLBU5150A11K
12.5	500	14	28	31.5	27.5	\	10	122	26	6.8	7.5	33	96 70	C4AQLBU5125A1YK
10	500	13	25	31.5	27.5	\	10	96 122	25	8.1	6.5	36	234	C4AQLBU5100A1XK
5.6	500	11	20	31.5	27.5	\	10	54	25	13.1	4.5	44	256	C4AQLBU4560A1WK
F.(I 500 I	11	00	01.5	07.5	U _{NDC} a				= 450 VDC; U _{OP105}			256	044010114560441414
					-		•	•						
(P1)		В	Н	L	Р	P1	V/µs	Apk	nH	mΩ	Arms	(°C/W)		
(µF)										KIIZ	KIIZ		Qualitity	NUMBER
Value	VDC			(111111)						kHz	kHz	(H3/AIIIU)	Quantity	NUMBER
	VDO			(mm)			dV/dt	lpkr	ESL		70°C at 10	(HS/Amb)	Packaging	PART
Cap			Din	nensi	ons		1577.14		E01	_	_	Rth		
										ESR	Irms*			

¹ Items available for sample.

^(*) Irms value that leads to a ΔT of $\approx 15^{\circ}C$ in the Hot Spot > $T_{HS} = T_{AMB} + \Delta T = 70^{\circ}C + 15^{\circ}C = 85^{\circ}C$



Table 1 - Ratings & Part Number Reference cont'd.

Cap Value (µF)	VDC			nensi (mm)			dV/dt	lpkr	ESL	ESR 70°C at 10 kHz	Irms* 70°C at 10 kHz	Rth (HS/Amb)	Packaging Quantity	PART NUMBER
(рі)		В	Н	L	P	P1	V/µs	Apk	nH	mΩ	Arms	(°C/W)		
						U _{NDC} at	70°C = 1,1	00 VDC; U	_{1P85} at 85°C	= 900 VDC; U _{OP10}	_s at 105°C = 700	VDC		
1.5	1100	11	20	31.5	27.5	\	24	36	25	26.3	3.5	44	256	C4AQQBU4150A1WJ
2.7	1100	13	25	31.5	27.5	\	24	65	25	15.3	5	36	234	C4AQQBU4270A1XJ
3.3	1100	14	28	31.5	27.5	\	24	79	26	12.9	5.5	33	96	C4AQQBU4330A1YJ
5	1100	19	29	31.5	27.5	\	24	120	26	9.1	7	29	72	C4AQQBU4500A11J
8	1100	22	37	31.5	27.5	١	24	193	28	6.6	9.5	23	64	C4AQQBU4800A12J
12	1100	20	40	42	37.5	10.2	16	190	30	6.3	10	20	58	C4AQQBW5120A3FJ
14	1100	28	37	42	37.5	10.2	16	229	30	5.4	11.5	18	36	C4AQQBW5140A3JJ
20	1100	30	45	42	37.5	20.3	16	321	30	3.9	15	15	36	C4AQQBW5200A3LJ
25	1100	35	50	42	37.5	20.3	16	409	35	2.8	19	13	30	C4AQQBW5250A3OJ
30	1100	30	45	57.5	52.5	20.3	11	324	35	5.2	15	12	27	C4AQQBW5300A3MJ
40	1100	35	50	57.5	52.5	20.3	11	428	35	4	18	10	23	C4AQQBW5400A3NJ
55 ¹	1100	45	56	57.5	52.5	20.3	11	595	41	2.6	24.5	8	18	C4AQQEW5550A3AJ
65 ¹	1100	45	65	57.5	52.5	20.3	11	717	45	2.3	28	7	18	C4AQQEW5650A3BJ
											₁₀₅ at 105°C = 850			
1	1300	11	20	31.5	27.5	\	28	28	25	33.1	3	44	256	C4AQUBU4100A1WJ
1.8	1300	13	25	31.5	27.5	\	29	52	25	19.1	4.5	36	234	C4AQUBU4180A1XJ
2.2	1300	14	28	31.5	27.5	\	29	63	26	16	5	33	96	C4AQUBU4220A1YJ
3.3	1300	19	29	31.5	27.5	\	29	95	26	11.2	6.5	29	72	C4AQUBU4330A11J
5	1300	22	37	31.5	27.5	\	29	145	28	8.2	8.5	23	64	C4AQUBU4500A12J
8	1300	20	40	42	37.5	10.2	20	157	30	7.9	9	20	58	C4AQUBW4800A3FJ
10	1300	28	37	42	37.5	10.2	20	196	30	6.3	11	18	36	C4AQUBW5100A3JJ
12	1300	30	45	42	37.5	20.3	20	235	30	5.3	13	15	36	C4AQUBW5120A3LJ
18 20	1300	35 30	50 45	42	37.5	20.3	19 13	350 262	35	3.2	18	13	30 27	C4AQUBW5180A30J
25	1300 1300	35	50	57.5 57.5	52.5 52.5	20.3	13	331	35 35	6.5 5.2	13 16	12 10	27	C4AQUBW5200A3MJ
25	1300	35	50	57.5	52.5	20.3	13	354	35	5.2 4.9	16.5	10	23	C4AQUBW5250A3NJ C4AQUBW5270A3NJ
38 ¹	1300	45	56	57.5	52.5	20.3	13	498	41	3.1	22.5	8	23 18	C4AQUEW5380A3AJ
45 ¹	1300	45	65	57.5	52.5	20.3	13	596	45	2.7	26	7	18	C4AQUEW5450A3BJ
45	1300	40	03	37.3	32.3						105°C = 900	,	10	C4AQULW3430A3D3
1.0	1500	11	20	31.5	27.5	\	31	31	24	25.7	3.5	44	256	C4AQSBU4100A1WJ
1.5	1500	13	25	31.5	27.5	\	31	49	25	17.7	4.5	36	234	C4AQSBU4150A1XJ
2.0	1500	14	28	31.5	27.5	\	32	49 65	25 26	14.1	4.5 5.5	33	96	C4AQSBU4200A1YJ
3.0	1500	19	29	31.5	27.5	\	32	95	26	9.7	5.5 7	29	72	C4AQSBU4300A11J
4.5	1500	22	37	31.5	27.5	\	33	148	28	7.3	9	23	64	C4AQSBU4450A12J
6.0	1500	20	40	42	37.5	10.2	22	132	30	8	9	20	58	C4AQSBW4600A3FJ
8.0	1500	28	37	42	37.5	10.2	22	176	30	6	11	18	36	C4AQSBW4800A3JJ
12	1500	30	45	42	37.5	20.3	22	256	33	4.1	14.5	15	36	C4AQSBW5120A3LJ
15	1500	35	50	42	37.5	20.3	22	326	35	3.5	17.5	13	30	C4AQSBW5150A30J
17	1500	30	45	57.5	52.5	20.3	14	236	35	5.9	13.5	12	27	C4AQSBW5170A3MJ
22	1500	35	50	57.5	52.5	20.3	14	308	38	4.6	17	10	23	C4AQSBW5220A3NJ
32 ¹	1500	45	56	57.5	52.5	20.3	14	460	41	3.4	22	8	18	C4AQSEW5320A3AJ
40 ¹	1500	45	65	57.5	52.5	20.3	14	562	45	2.8	25	7	18	C4AQSEW5400A3BJ
		R	Н	L	P	P1	V/µs	Apk	nH	mΩ	Arms	(°C/W)		
Cap		ـ د	<u> </u>		<u> </u>	FI	v/µ3	why	шп	ESR	Irms*	(0/11)	Packaging	PART
Value (µF)	VDC		Dime	nsions	(mm)		dV/dt	lpkr	ESL	70°C at 10 kHz	70°C at 10 kHz	Rth (HS/Amb)	Quantity	NUMBER

¹ Items available for sample.

^(*) Irms value that leads to a ΔT of $\approx 15^{\circ}C$ in the Hot Spot > $T_{HS} = T_{AMB} + \Delta T = 70^{\circ}C + 15^{\circ}C = 85^{\circ}C$



Soldering Process

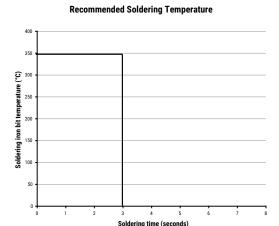
The implementation of the RoHS directive has resulted in the selection of SnAgCu (SAC) alloys or SnCu alloys as primary solder. This has increased the liquidus temperature from that of 183°C for SnPb eutectic alloy to 217 – 221°C for the new alloys. As a result, the heat stress to the components, even in wave soldering, has increased considerably due to higher pre-heat and wave temperatures. Polypropylene capacitors are especially sensitive to heat (the melting point of polypropylene is 160 – 170°C). Wave soldering can be destructive, especially for mechanically small polypropylene capacitors (with lead spacing of 5 mm to 15 mm), and great care has to be taken during soldering. The recommended solder profiles from KEMET should be used. Please consult KEMET with any questions. In general, the wave soldering curve from IEC Publication 61760-1 Edition 2 serves as a solid guideline for successful soldering. Please see Figure 1.

Reflow soldering is not recommended for through-hole film capacitors. Exposing capacitors to a soldering profile in excess of the above the recommended limits may result to degradation or permanent damage to the capacitors.

Do not place the polypropylene capacitor through an adhesive curing oven to cure resin for surface mount components. Insert through-hole parts after the curing of surface mount parts. Consult KEMET to discuss the actual temperature profile in the oven, if through-hole components must pass through the adhesive curing process. A maximum two soldering cycles is recommended. Please allow time for the capacitor surface temperature to return to a normal temperature before the second soldering cycle.

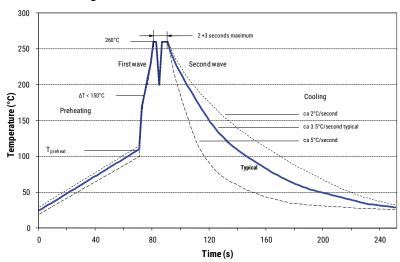
Manual Soldering Recommendations

Following is the recommendation for manual soldering with a soldering iron.



The soldering iron tip temperature should be set at 350°C (+10°C maximum) with the soldering duration not to exceed more than 3 seconds.

Wave Soldering Recommendations





Soldering Process cont'd

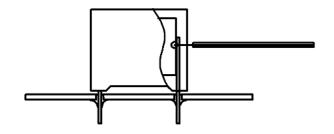
Wave Soldering Recommendations cont'd

1. The table indicates the maximum set-up temperature of the soldering process Figure 1

Dielectric		imum Pre emperatu	Maximum Peak Soldering Temperature		
Film Material	Capacitor Pitch ≤ 10 mm	Capacitor Pitch = 15 mm	Capacitor Pitch > 15 mm	Capacitor Pitch ≤ 15 mm	Capacitor Pitch > 15 mm
Polyester	130°C	130°C	130°C	270°C	270°C
Polypropylene	100°C	110°C	130°C	260°C	270°C
Paper	130°C	130°C	140°C	270°C	270°C
Polyphenylene Sulphide	150°C	150°C	160°C	270°C	270°C

2. The maximum temperature measured inside the capacitor: Set the temperature so that inside the element the maximum temperature is below the limit:

Dielectric Film Material	Maximum temperature measured inside the element				
Polyester	160°C				
Polypropylene	110°C				
Paper	160°C				
Polyphenylene Sulphide	160°C				



Temperature monitored inside the capacitor.

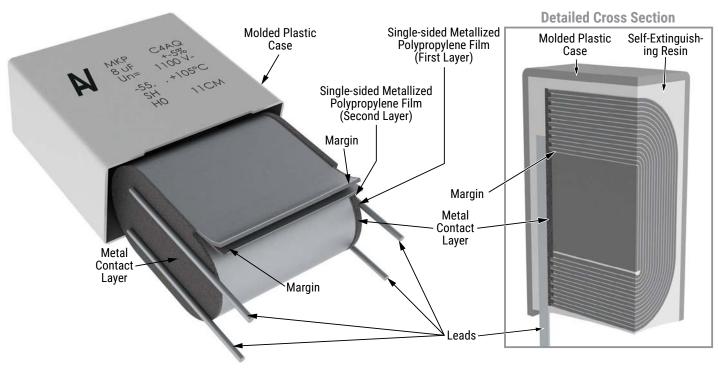
Selective Soldering Recommendations

Selective dip soldering is a variation of reflow soldering. In this method, the printed circuit board with through-hole components to be soldered is preheated and transported over the solder bath as in normal flow soldering without touching the solder. When the board is over the bath, it is stopped and pre-designed solder pots are lifted from the bath with molten solder only at the places of the selected components, and pressed against the lower surface of the board to solder the components.

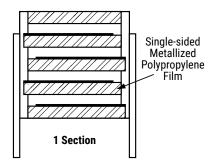
The temperature profile for selective soldering is similar to the double wave flow soldering outlined in this document, however, instead of two baths, there is only one bath with a time from 3 to 10 seconds. In selective soldering, the risk of overheating is greater than in double wave flow soldering, and great care must be taken so that the parts are not overheated.



Construction

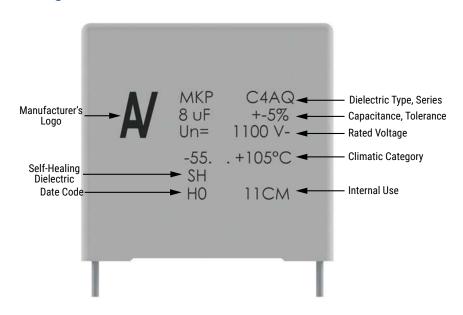


Winding Scheme





Marking



Manufacturing Date Code (IEC-60062)			
Y = Year, Z = Month			
Year	Code	Month	Code
2010	А	January	1
2011	В	February	2
2012	С	March	3
2013	D	April	4
2014	Е	May	5
2015	F	June	6
2016	Н	July	7
2017	J	August	8
2018	K	September	9
2019	L	October	0
2020	М	November	N
2021	N	December	D
2022	Р		
2023	R		
2024	S		
2025	T		
2026	U		
2027	V		
2028	W		
2029	Х		
2030	Α		



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